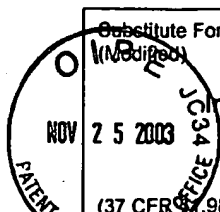


Substitute Form PTO-1449 (Modified) 	U.S. Department of Commerce Patent and Trademark Office		Attorney's Docket No. 13909-103001	Application No. 10/673,561
	Information Disclosure Statement by Applicant (Use several sheets if necessary)		Applicant Axel Spriestersbach et al.	
			Filing Date September 30, 2003	Group Art Unit Unknown

U.S. Patent Documents

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA						
	AB						
	AC						
	AD						
	AE						

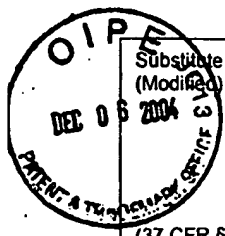
Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AF							
	AG							
	AH							
	AI							
	AJ							

Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
MEK	AK	XML Events, An Events Syntax for XML, W3C Working Draft 12 August 2002, http://www.w3.org/R/2002/WD-xml-events-20020812 , pp. 1-25.
MEK	AL	W3C, XForms 1.0, W3C Candidate Recommendation 12 November 2002. Retrieved 2/5/2003 from http://www.w3.org/TR/200/CR-xforms-20021112/ , pp. 1-142.
MEK	AM	XMLDocs, Web-based XML Editing and Document Management, WAP/WML Tutorial. Retrieved 2/5/2003 from http://www.w3schools.com/wap/default.asp , pp. 1-3.
MEK	AN	DDL FAQ, General questions (3 pages).
MEK	AO	Claude Seyrat, EXPWAY, Description Definition Language, Tutorial (39 pages).

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Substitute Form PTO-1449
(Modified)U.S. Department of Commerce
Patent and Trademark OfficeAttorney's Docket No.
13909-103001Application No.
10/673,561**Information Disclosure Statement
by Applicant**

(Use several sheets if necessary)

(37 CFR §1.98(b))

Applicant
Axel Priestersbach et al.Filing Date
September 30, 2003Group Art Unit
2153**U.S. Patent Documents**

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
MEK	AA	US2002/0035579 A1	03/21/2002	Wang et al.			

Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
MEK	AB	WO01/86462 A1	11/15/2001	WIPO				
MEK	AC	GB 2 364 802 A	02/06/2002	Great Britain				

Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
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Examiner Signature

/Michael Keefer/

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